Notice of References Cited Application/Control No. 09/783,254 Examiner Hieu Phan Applicant(s)/Patent Under Reexamination SIRHAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,283,257	02-1994	Gregory et al.	514/458
	В	US-			
	C	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	н	US-			
	_	US-			
	Ĺ	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т			4		

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	W					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.